Application/Control No. Applicant(s)/Patent Under Reexamination FUJIBAYASHI ET AL. 10/772,297 **Notice of References Cited** Art Unit Examiner Page 1 of 1 2121 **Sunray Chang** U.S. PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Classification Name MM-YYYY 318/85 05-2005 Fujibayashi et al. US-6,897,626 Α US-В US-C US-D US-Ε US-F US-G USн US-1 US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Name Classification Country MM-YYYY Country Code-Number-Kind Code N 0 P Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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